

M8 NO CLEAN SOLDER PASTE

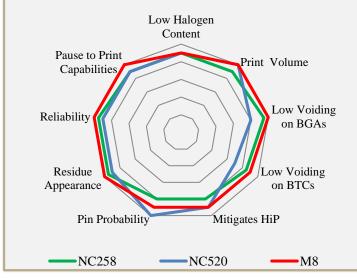
FEATURES

- ▶ Low Voiding: <5% on BGA and <10% on BTC
- Excellent Print Transfer Efficiencies <0.50 AR</p>
- Eliminates HiP Defects
- REACH and RoHS* Compliant
- Formulated for use with T4 and Finer Powders
- Powerful Wetting on Lead-Free Surface Finishes
- Minimal Transparent Residue LED Compliant
- Passes Bono and Automotive SIR Testing

DESCRIPTION

M8 no clean solder paste brings performance to the next level. Developed in combination with T4 and finer mesh leaded and lead-free alloy powders, M8 provides stable transfer efficiencies required for today's UFP and umBGA devices, reducing DPMO on the most challenging applications. M8 activators will reduce wetting related defects such as HiP (head-in-pillow) and provide smooth shiny joints. M8 has reduced BGA and BTC voiding to as low as <5% on BGA and <10% on BTC ground pads. M8 passes stringent automotive and high reliability SIR and electrochemical test requirements.

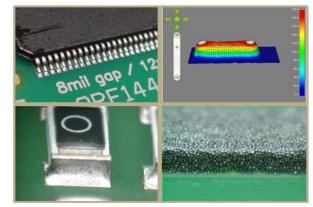
CHARACTERISTICS



*Lead-free alloys.

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DISCLAIMER The information contained herein is based on data considered accurate and is offered at no charge. Product information is based upon the assumption of proper handling and operating conditions. Liability is expressly disclaimed for any loss or injury arising out of the use of this information or the use of any materials designated. Please refer to http://www.aimsolder.com/terms-conditions to review AIM's terms and conditions.



HANDLING & STORAGE

PARAMETER	TIME	TEMPERATURE	
Sealed Refrigerated Shelf Life	1 year	0°C-12°C (32°F- 55°F)	
Sealed Unrefrigerated	3 months	< 25°C (< 77°F)	
Shelf Life	5 monuis	$\langle 25 C (\langle 77 1 \rangle)$	

Do not add used paste to unused paste. Store used paste separately; keep unused paste tightly sealed with internal plug or end cap in place. After opening, solder paste shelf life is environment and application dependent. See AIM's paste handling guidelines for further information. Alloy and storage conditions may affect shelf life. Please refer to M8 Certificate of Analysis for product specific information.

CLEANING

Pre-Reflow: AIM DJAW-10 effectively removes M8 solder paste from stencils while in process. DJAW-10 can be hand applied or used in under stencil wipe equipment. DJAW-10 will not dry M8 and will enhance transfer properties. Do not over-apply DJAW-10. Do not apply DJAW-10 to stencil topside. Isopropanol (IPA) is not recommended in process but may be used as a final stencil rinse.

Post-Reflow Flux Residue: M8 residues can remain on the assembly after reflow and do not require cleaning. Where cleaning is mandated, AIM has worked closely with industry partners to ensure that M8 residues can be effectively removed with common defluxing agents. Contact AIM for cleaning compatibility information.



REFLOW PROFILE

Detailed profile information may be found at http://www.aimsolder.com/reflow-profile-supplements. Contact AIM for additional information.

PRINTING

RECOMMENDED INITIAL PRINTER SETTINGS - DEPENDENT ON PCB AND PAD DESIGN		
Parameter	Recommended Initial Settings	
Squeegee Pressure	0.4 - 0.7kg/25mm	
Squeegee Speed	13 – 152 mm/second	
Snap-off Distance	On Contact 0.00 mm	
PCB Separation Distance	0.75 - 2.0 mm	
PCB Separation Speed	3 - 20 mm/second	
Solder Paste Stencil Life	>8 hours	

TEST DATA SUMMARY

NAME	TEST METHOD		RESULTS
IPC Flux Classification	J-STD-004 A	ROLO	
IPC Flux Classification	J-STD-004 B and C	ROL1	
NAME	TEST METHOD	TYPICAL RESULTS	IMAGE
Mass Density*		4.2 gr/cm ³ (*SAC305)	
Copper Mirror	J-STD-004B 3.4.1.1 IPC-TM-650 2.3.32	LOW	N. 20441, MTH MCRR. 33270
Corrosion	J-STD-004B 3.4.1.2 IPC-TM-650 2.6.15	PASS	Before After
Quantitative Halides	J-STD-004B 3.4.1.3 IPC-TM-650 2.3.28.1	Cl: 0.0% Typical	
Qualitative Halides, Silver Chromate	J-STD-004B 3.5.1.1 IPC-TM-650 2.3.33	PASS	
Qualitative Halides, Fluoride Spot	J-STD-004B 3.5.1.2 IPC-TM-650 2.3.35.1	No Fluoride	

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NAME	TEST METHOD	TYPICAL RESULTS	IMAGE
Surface Insulation Resistance	J-STD-004B 3.4.1.4 IPC-TM-650 2.6.3.7	All measurement s on test patterns exceed 100 MΩ	13 1
Bono Testing		PASS Fc<8.0 Typical	
Oxygen Bomb Halogen Testing	EN14582:2007 SW 9056 SW 5050	Cl <122 mg/Kg	
Electrochemical Migration	J-STD-004B 3.4.1.5 IPC-TM-650 2.6.14.1	PASS	
Flux Residue Dryness	IPC-TM-650 2.4.47	PASS	Before After
Flux Solids, Nonvolatile Determination	J-STD-004B 3.4.2.1 IPC-TM-650 2.3.34	94.8% Typical	
Acid Value Determination	J-STD-004B 3.4.2.2 IPC-TM-650 2.3.13	136 mgKOH/g flux Typical	
Viscosity (Brookfield)	J-STD-005A 3.5.1 IPC-TM-650 2.4.34	400-1000 Kcps	Formula Dependent
Viscosity (Malcom)	J-STD005A 3.5.1 IPC- TM650 2.4.34	70-300 Pa.S	Formula Dependent

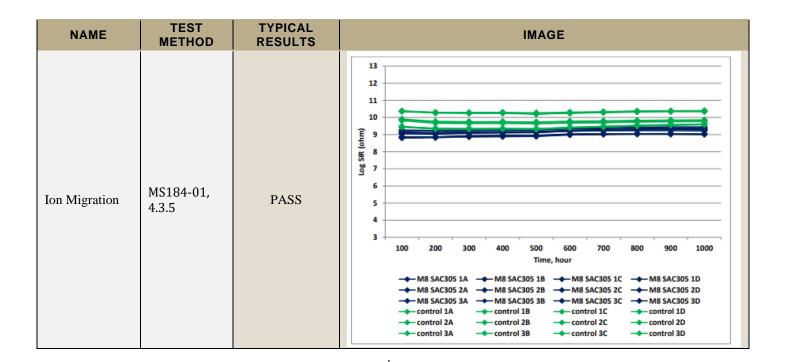
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NAME	TEST METHOD	TYPICAL RESULTS	IMAGE
Visual	J-STD-004B 3.4.2.5	PASS	
Slump	J-STD-005A 3.6 IPC-TM-650 2.4.35	PASS	
Spread Test	J-STD-004B 3.7.2 IPC-TM-650 2.4.46	PASS	
Solder Ball	J-STD-005A 3.7 IPC-TM-650 2.4.43	PASS	15 min 4 hrs
Tack	J-STD-005A 3.8 IPC-TM-650 2.4.44	36.1 gf Time 0 Typical	Tack M8 SAC305 88.5 T4 100.00 50.00 50.00 0.00 0.00 2 4 6 8 10
Tack	JIS Z 3284	105.92 gf Typical	M8 SAC305

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